## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10567481	SHEN ET AL.
Examiner	Art Unit
M. Lee	2622

SEARCHED						
Class	Subclass	Date	Examiner			
348	725, 552-558, 705, 706	3/2/09	ml			

SEARCH NOTES					
Search Notes	Date	Examiner			
east	3/2/09	ml			

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

	/M. Lee/ Primary Examiner.Art Unit 2622
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